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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/588,163	08/01/2006	Atsushi Yamaguchi	128939	4113
25944 OLIFF & BERI	7590 11/14/200 RIDGE, PLC	EXAMINER		
P.O. BOX 3208	350	KIM, PETER B		
ALEXANDRIA, VA 22320-4850			ART UNIT	PAPER NUMBER
			2851	
			MAIL DATE	DELIVERY MODE
			11/14/2008	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

	Application No.	Applicant(s)			
	10/588,163	YAMAGUCHI, ATSUSHI			
Office Action Summary	Examiner	Art Unit			
	Peter B. Kim	2851			
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	orrespondence address			
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA  - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication.  - If NO period for reply is specified above, the maximum statutory period w  - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tim vill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE	lely filed the mailing date of this communication. (35 U.S.C. § 133).			
Status					
1) Responsive to communication(s) filed on 24 Ju	action is non-final. nce except for formal matters, pro				
Disposition of Claims					
4)  Claim(s) 1-49 is/are pending in the application.  4a) Of the above claim(s) is/are withdray  5)  Claim(s) is/are allowed.  6)  Claim(s) 1-49 is/are rejected.  7)  Claim(s) is/are objected to.  8)  Claim(s) are subject to restriction and/or  Application Papers  9)  The specification is objected to by the Examine  10)  The drawing(s) filed on 01 August 2006 is/are:  Applicant may not request that any objection to the or papers	vn from consideration. r election requirement. r. a)⊠ accepted or b)□ objected the drawing(s) be held in abeyance. See	e 37 CFR 1.85(a).			
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).  11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.					
Priority under 35 U.S.C. § 119					
12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).  a) All b) Some * c) None of:  1. Certified copies of the priority documents have been received.  2. Certified copies of the priority documents have been received in Application No  3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).  * See the attached detailed Office action for a list of the certified copies not received.					
Attachment(s)  1) Notice of References Cited (PTO-892)  2) Notice of Draftsperson's Patent Drawing Review (PTO-948)  3) Information Disclosure Statement(s) (PTO/SB/08) Paper No(s)/Mail Date 10/27/2006, 10/13/2006.	4)  Interview Summary Paper No(s)/Mail Da 5)  Notice of Informal P 6)  Other:	ite			

## **DETAILED ACTION**

## Election/Restrictions

In response to applicant's arguments filed on July 24, 2008 and after a review of the claims, the restriction requirement is withdrawn and claims 1-49 are examined.

## **Specification**

The disclosure is objected to because of the following informalities: The letter "L" of pages 57, 59, 61, and 62 are not clearly defined.

Appropriate correction is required.

## Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1-29, 34-47 and 49 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tanimoto et al. (Tanimoto) (5,151,749) in view of Streefkerk et al. (Streefkerk) (2006/0007419).

Tanimoto discloses an exposure apparatus (Fig. 1) which exposes a substrate (W) by radiating an exposure light beam, an exposure method and a position control method and a method for producing a device comprising a mover (ST) which holds the substrate (W), a driving unit (30X and 30Y) which moves the mover and an interferometer (XI, YI) system which radiates a measuring light beam onto a reflecting surface (MX, MY) formed on the mover and which receives a reflected light beam therefrom to measure position information about a position

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of the mover; and a memory (col. 9, lines 1-10) which stores error information about an error of the reflecting surface (col. 7, line 61 - col. 9, line 45). Tanimoto discloses a control unit (50) which controls the driving unit and which includes control information for moving the mover in the absence of the liquid wherein the control unit controls the driving unit (col. 7, lines 15-57) and projecting the patterned image (R) onto the substrate on the basis of the error information (Fig. 1). Tanimoto discloses correction information to control movement of the mover by compensating the error of the reflecting surface (col. 8, lines 58-65), and discloses controlling the position on the error information and the position measured by the interferometer system when a plurality of marks on the substrate are detected (col. 4, lines 29-63). Tanimoto discloses the error of the reflecting surface including warpage (curving) and inclination (col. 7, lines 61-67), and the reflecting surface formed in a first direction and the information includes a plurality of pieces of information corresponding to a plurality of positions in a second direction perpendicular to the first direction (col. 7, line 61 - col. 9, line 45, Fig. 5), wherein the mover has a second reflection surface which extends in the second direction (MX, MY) and the error information includes a plurality of pieces of information corresponding to a plurality of positions in the first direction, as the error information about the error of the second reflecting surface (col. 7, line 61 - col. 9, line 45). However, Tanimoto does not disclose the exposing the substrate through a liquid, determining the error information of the reflecting surface in the presence of the liquid and the controlling the driving unit and including control information for moving the mover in the presence of the liquid supplied onto the mover. Streefkerk discloses in an immersion lithographic system (Fig. 2 and 5) which improves the resolution over the exposure apparatus which does not use the immersion liquid and in para 0048 that liquid that might

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migrate over the sides of the substrate table onto the mirrors for the interferometer system may cause errors or interfere with the operation. Therefore, it would have been obvious to one of ordinary skill in the art at the time of the invention to obtain the error information under dry condition and the condition when the immersion liquid is supplied when using an immersion liquid exposure system to improve the resolution since as taught by Streefkerk the liquid might migrate over the sides to the reflecting surfaces.

Claims 30-33 and 48 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tanimoto et al. (Tanimoto) (5,151,749) in view of Streefkerk et al. (Streefkerk) (2006/0007419) and Loopstra et al. (Loopstra) (5,969,441).

Tanimoto in view of Streefkerk discloses the claimed invention as discussed above; however, the modified Tanimoto does not disclose an exposure station and a measuring station. Loopstra discloses an exposure station and a measuring station (Fig. 1). Therefore, it would have been obvious to one of ordinary skill in the art at the time of the invention to further modify Tanimoto by providing the separate exposure and measuring station and obtaining the control information for moving the mover in the presence of the liquid at the exposure station and the information for moving the mover in the absence of the liquid at the measuring station in order to improve the throughput since the measurement of one substrate and mover can take place while another is being exposed.

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Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Peter B. Kim whose telephone number is (571) 272-2120. The examiner can normally be reached on 9:00 AM - 5:30 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Diane Lee can be reached on (571) 272-2399. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/Peter B. Kim/ Primary Examiner, Art Unit 2851

November 8, 2008